Application/Control No. Applicant(s)/Patent Under Reexamination 10/813,824 SELF ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Daniel P. Stephenson 3672 **U.S. PATENT DOCUMENTS** Document Number Date Classification Country Code-Number-Kind Code MM-YYYY Webb et al. US-5,957,222 A 09-1999 175/45 US-2002/0066598 A1 06-2002 Rozendaal et al. 175/53 US-5,429,198 A 07-1995 Anderson et al. 175/230 С 08-2003 US-2003/0152428 A1 Wentworth et al. 405/184.2 D US-5,490,569 A 02-1996 Brotherton et al. 175/61 Ε US-6,755,263 B2 06-2004 Alft et al. 175/61 F US-6,491,115 B2 12-2002 Van Houwelingen et al. 175/27 G US-5,979,574 A 11-1999 Osadchuk, Mark 175/353 Н US-2004/0028476 A1 02-2004 Payne et al. 405/184 US-2003/0131992 A1 07-2003 Michael et al. 166/255.2 .1 US-2003/0063013 A1 04-2003 Jin et al. 340/853.3 Κ US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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